



MATRA M H S

T-46-23-12

September 1990

DATA SHEET

HM 65728

2 k x 8 HIGH SPEED CMOS SRAM

FEATURES

- FAST ACCESS TIME
MILITARY : 35/45/55 ns (max)
COMMERCIAL : 20/25/35/45/55 ns (max)
- LOW POWER CONSUMPTION
ACTIVE : 310 mW (typ)
STANDBY : 55 mW (typ)
- WIDE TEMPERATURE RANGE :
- 55°C TO + 125°C
- 300 AND 600 MILS WIDTH PACKAGE
- TTL COMPATIBLE INPUTS AND OUTPUTS
- ASYNCHRONOUS
- CAPABLE OF WITHSTANDING GREATER THAN 2000 V ELECTROSTATIC DISCHARGE
- SINGLE 5 VOLT SUPPLY

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DESCRIPTION

The HM 65728 is a high speed CMOS static RAM organized as 2048 x 8 bits. It is manufactured using MHS's high performance CMOS technology.

Access times as fast as 20 ns are available with maximum power consumption of only 600 mW.

The HM 65728 features fully static operation requiring no external clocks or timing strobes. The automatic power-down feature reduces the power consumption by 80 % when the circuit is deselected.

Easy memory expansion is provided by an active low chip select (CS) and active low output enable (OE) and three state drivers.

All inputs and outputs of the HM 65728 are TTL compatible and operate from single 5V supply thus simplifying system design.

The HM 65728 is processed following the test methods of MIL STD 883C.

PACKAGES

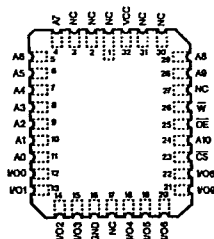
Plastic 300 & 600 mils, 24 pins, DIL
SO 300 mils, 24 pins
Tape and Reel Service

Ceramic 300 mils, 24 pins, DIL
LCC, 32 pins

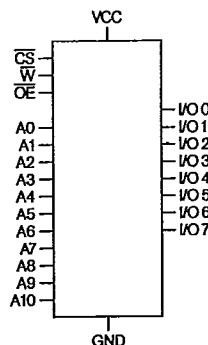
Pinout DIL 24 pins (top view)

Pinout LCC 32 pins (top view)

A7	1	24	VCC
A6	2	23	A8
A5	3	22	A9
A4	4	21	W
A3	5	20	OE
A2	6	19	A10
A1	7	18	CS
A0	8	17	I/O7
I/O0	9	16	I/O6
I/O1	10	15	I/O5
I/O2	11	14	I/O4
GND	12	13	I/O3

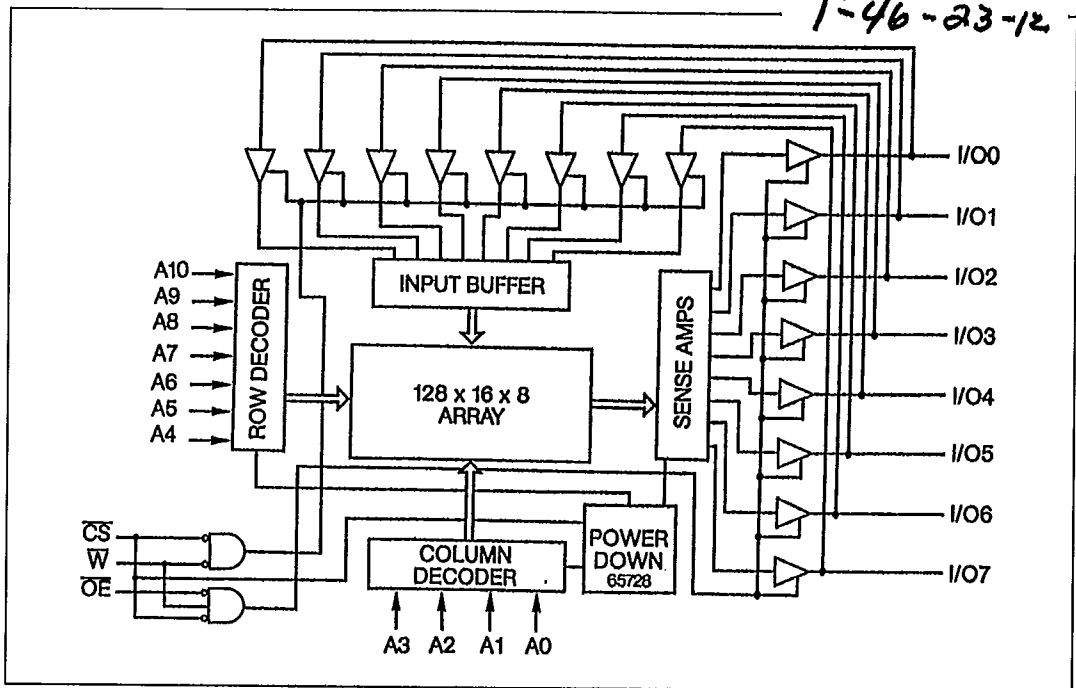


LOGIC SYMBOL



BLOCK DIAGRAM

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PIN NAMES

A0-A10 : Address inputs	$\overline{CS}$: Chip Select
I/O0-I/O7 : Input/Output	$\overline{OE}$: Output Enable
Vcc : Power	$\overline{W}$: Write enable
Gnd : Ground	

TRUTH TABLE

$\overline{CS}$	$\overline{OE}$	$\overline{W}$	DATA-IN	DATA-OUT	MODE
H	X	X	Z	Z	Deselect
L	L	H	Z	Valid	Read
L	H	L	Valid	Z	Write
L	L	L	Valid	Z	Write

ABSOLUTE MAXIMUM RATINGS

Supply voltage to GND potential : $-0.5\text{ V to }+7.0\text{ V}$
 DC input voltage : $-3.0\text{ V to }+7.0\text{ V}$
 DC output voltage in high Z state : $-0.5\text{ V to }+7.0\text{ V}$

Storage temperature : $-65^{\circ}\text{C to }+150^{\circ}\text{C}$
 Output current into outputs (low) : 20 mA

OPERATING RANGE*T-46-23-12*

		OPERATING VOLTAGE	OPERATING TEMPERATURE
Military	(- 2)	$5\text{ V} \pm 10\%$	$-55^{\circ}\text{C to }+125^{\circ}\text{C}$
Commercial	(- 5)	$5\text{ V} \pm 10\%$	$0^{\circ}\text{C to }+70^{\circ}\text{C}$

RECOMMENDED DC OPERATING CONDITIONS

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
Vcc	Supply voltage	4.5	5.0	5.5	V
Gnd	Ground	0.0	0.0	0.0	V
VIL	Input low voltage	-3.0	0.0	0.8	V
VIH	Input high voltage	2.0	—	5.5	V

CAPACITANCE

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
Cin (1)	Input capacitance	—	—	5	pF
Cout (1)	Output capacitance	—	—	7	pF

Note : 1. $T_A = 25^{\circ}\text{C}$, $f = 1\text{ MHz}$, $V_{cc} = 5.0\text{ V}$, these parameters are not tested.

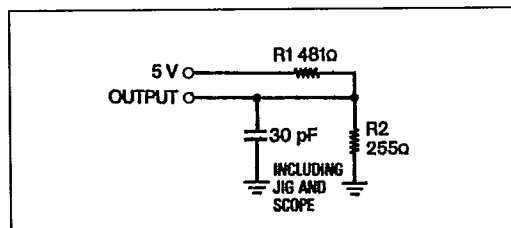
AC TEST LOADS WAVEFORMS

Fig. 1a.

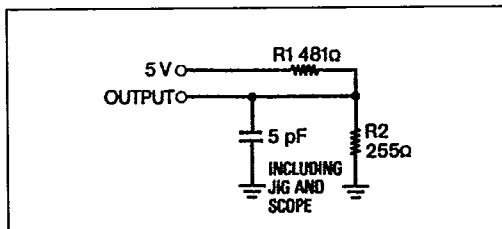


Fig. 1b.

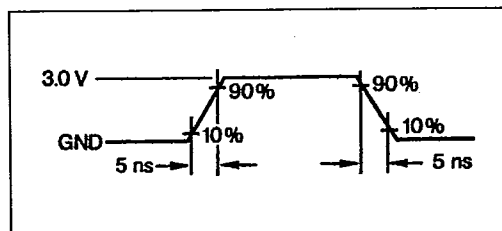
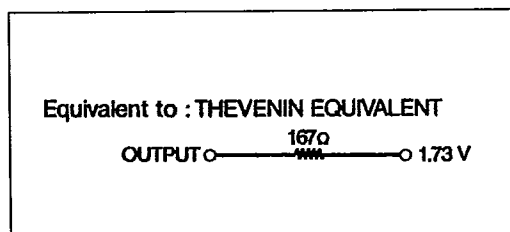


Figure 2 : All Input Pulses.

ELECTRICAL CHARACTERISTICS DC PARAMETER

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PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
IIX (2)	Input leakage current	- 10.0	-	10.0	μ A
IOZ (3)	Output leakage current	- 40.0	-	40.0	μ A
IOS (3)	Output short circuit current	-	-	- 300.0	mA
VOL (4)	Output low voltage	-	-	0.4	V
VOH (4)	Output high voltage	2.4	-	-	V

- Notes : 2. Gnd < Vin < Vcc, Gnd < Vout < Vcc Output disabled.
 3. Vcc = max, Vout = Gnd, duration of the short circuit should not exceed 30 seconds.
 Not more than 1 output should be shorted at one time.
 4. Vcc min, IOL = 8.0 mA.
 5. Vcc min, IOH = - 4.0 mA.

Consumption for Commercial specification :

SYMBOL	PARAMETER	65728 F-5	65728 H-5	65728 K-5	65728 M-5	65728 N-5	UNIT	VALUE
ICCSB (6)	Standby supply current	40	20	20	20	30	mA	max
ICCOP (7)	Dynamic Operating current	100	100	100	100	100	mA	max

Consumption for Military specification :

SYMBOL	PARAMETER	65728 H-2*	65728 K-2	65728 M-2	65728 N-2	UNIT	VALUE
ICCSB (6)	Standby supply current	40	30	30	30	mA	max
ICCOP (7)	Dynamic Operating current	120	120	120	120	mA	max

- Notes : 6. $\overline{CS} \geq V_{IH}$, a pull up resistor to Vcc on the CS input is required to keep the device deselected during Vcc power-up otherwise ICCSB will exceed values above.
 7. Vcc max, Output current = 0 mA, f = max, Vin = Vcc or Gnd.
 * Preliminary specification.

ELECTRICAL CHARACTERISTICS AC PARAMETERS

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AC CONDITIONS :

Input pulse levels : Gnd to 3.0 V
 Input rise : 5 ns

Input timing reference levels : 1.5 V
 Output loading IOL/IOH (see figure 1a and 1b) : + 30 pF

WRITE CYCLE : Commercial Specification

SYMBOL	PARAMETER	65728 F-5	65728 H-5	65728 K-5	65728 M-5	65728 N-5	UNIT	VALUE
TAVAV	Write cycle time	20	25	35	45	55	ns	min
TAVWL	Address set-up time	0	0	0	0	0	ns	min
TAVWH	Address valid to end of write	20	20	30	40	50	ns	min
TDVWH	Data set-up time	15	15	15	20	25	ns	min
TELWH	$\overline{CS}$ low to write end	20	20	30	40	50	ns	min
TWLQZ (8)	Write low to high Z	10	10	15	15	20	ns	max
TWLWH	Write pulse width	15	20	20	20	30	ns	min
TWHAX	Address hold to end of write	0	2	2	2	2	ns	min
TWHDX	Data hold time	0	0	0	0	5	ns	min
TWHQX (8, 9)	Write high to low Z	3	3	0	0	0	ns	min
TEHAX	Address hold end $\overline{CS}$	3	3	3	3	3	ns	min

Notes : 8. The data input set up and hold timing should be referenced to the rising edge of the signal that terminates the write.

9. At any given temperature and voltage condition, TWHQX is less than TWLQZ for all devices. These parameters are sampled and not 100 % tested.

* Preliminary specification.

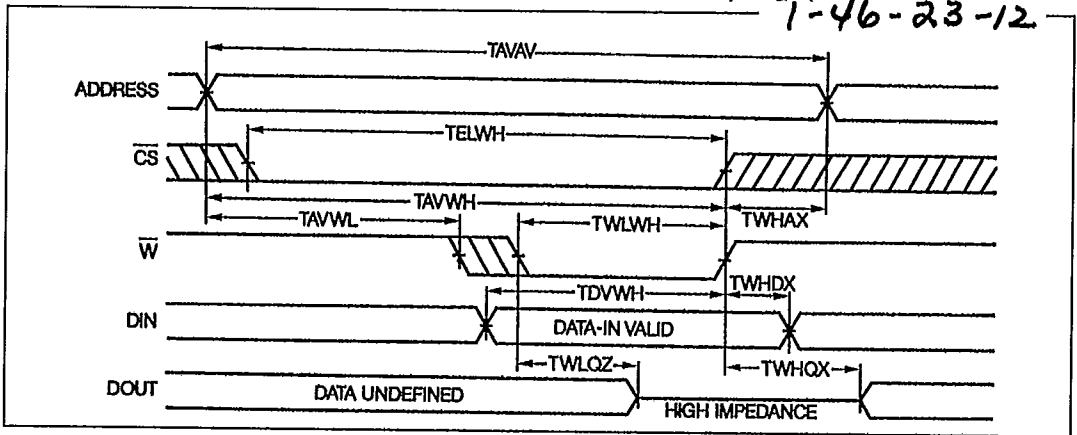
WRITE CYCLE : Military specification

SYMBOL	PARAMETER	65728 H-2*	65728 K-2	65728 M-2	65728 N-2	UNIT	VALUE
TAVAV	Write Cycle time	25	35	45	55	ns	min
TAVWL	Address set-up time	0	0	0	0	ns	min
TAVWH	Address valid to end of write	20	30	40	50	ns	min
TDVWH	Data set-up time	10	15	20	25	ns	min
TELWH	$\overline{CS}$ low to write end	20	30	40	50	ns	min
TWLQZ (8)	Write low to high Z	10	15	15	20	ns	max
TWLWH	Write pulse width	20	20	25	30	ns	min
TWHAX	Address hold to end of write	2	2	2	2	ns	min
TWHDX	Data hold time	5	5	5	5	ns	min
TEHAX	Address hold end $\overline{CS}$	3	3	3	3	ns	min

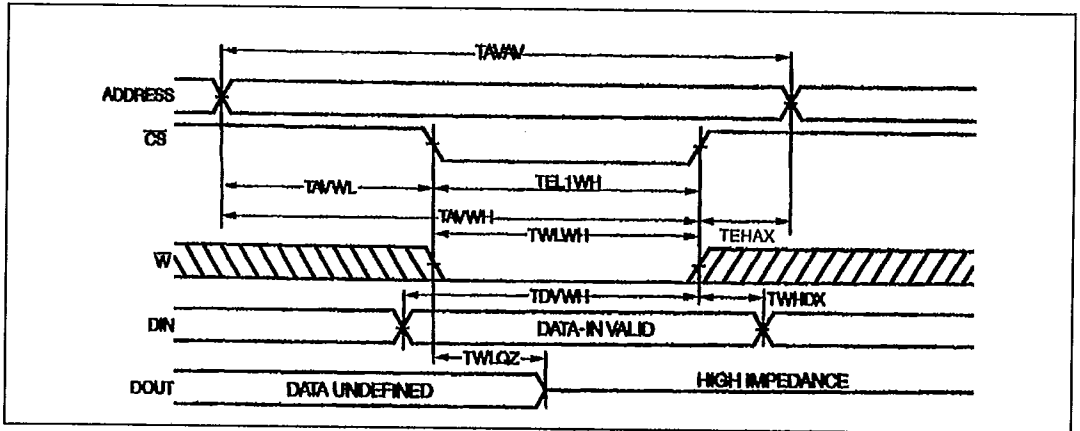
* Preliminary specification

WRITE CYCLE 1 ($\overline{W}$ CONTROLLED)

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WRITE CYCLE 2 ($\overline{CS}$ CONTROLLED)



READ CYCLE : Commercial specification

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SYMBOL	PARAMETER	65728 F-5	65728 H-5	65728 K-5	65728 M-5	65728 N-5	UNIT	VALUE
TAVAV	Read cycle time	20	25	35	45	55	ns	min
TAVQV	Address access time	20	25	35	45	55	ns	max
TAVQX	Address valid to low Z	3	3	5	5	5	ns	min
TELQV	Chip-select access time	20	25	35	45	55	ns	max
TELQX	$\overline{CS}$ low to low Z	3	3	5	5	5	ns	min
TEHQZ	$\overline{CS}$ high to high Z	12	12	15	20	20	ns	max
TELIC	$\overline{CS}$ low to power up	0	0	0	0	0	ns	min
TEHICL	$\overline{CS}$ high to power down	15	15	20	25	25	ns	max
TGLQV	Output enable access time	10	15	15	20	25	ns	max
TGLQX	$\overline{OE}$ low to low Z	2	2	0	0	0	ns	min
TGHQZ	$\overline{OE}$ high to high Z	10	10	15	15	20	ns	max

READ CYCLE : Military specification

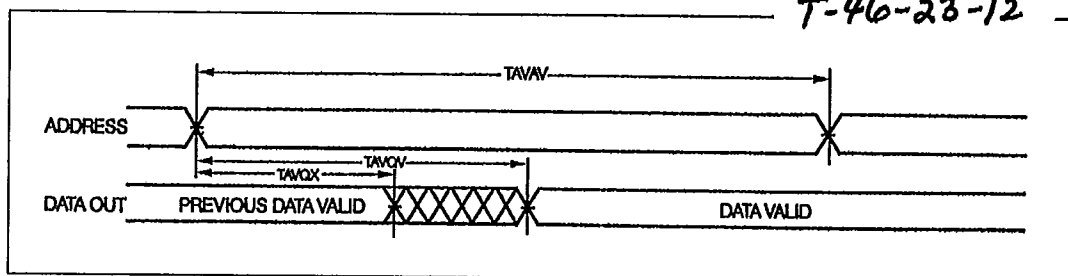
SYMBOL	PARAMETER	65728 H-2*	65728 K-2	65728 M-2	65728 N-2	UNIT	VALUE
TAVAV	Read cycle time	25	35	45	55	ns	min
TAVQV	Address access time	25	35	45	55	ns	max
TAVQX	Address valid to low Z	3	5	5	5	ns	min
TELQV	Chip-select access time	25	35	45	55	ns	max
TELQX	$\overline{CS}$ low to low Z	3	5	5	5	ns	min
TEHQZ	$\overline{CS}$ high to high Z	12	15	20	20	ns	max
TELIC	$\overline{CS}$ low to power up	0	0	0	0	ns	min
TEHICL	$\overline{CS}$ high to power down	20	20	25	25	ns	max
TGLQV	Output enable access time	12	15	20	25	ns	max
TGLQX	$\overline{OE}$ low to low Z	0	0	0	0	ns	min
TGHQZ	$\overline{OE}$ high to high Z	12	15	15	20	ns	max

* Preliminary specification

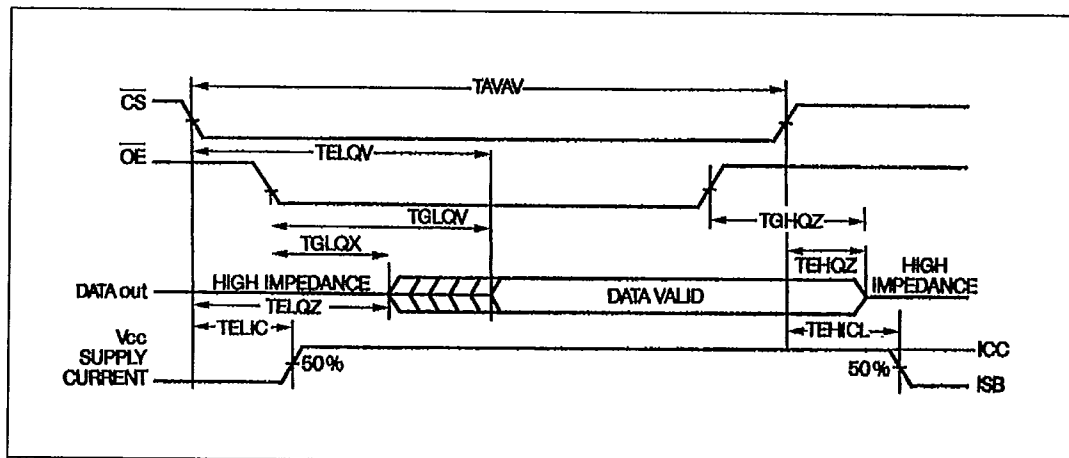
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READ CYCLE nb 1

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READ CYCLE nb 2



ORDERING INFORMATION

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Package	Device type	Grade	Level	
HM1	65728 (A)	H	- 5 : R	Tape and Reel Service
	2 k x 8 high speed static RAM			
0 - Chip form		F = 20 ns	- 5 : Commercial	
1 - Ceramic 24 pins		H = 25 ns	- 2 : Military	
3 - Plastic 24 pins		K = 35 ns	- 8 : Military with B.I.	
300 mils		M = 45 ns	(B.I. = Burn-In)	
3E - Plastic 24 pins		N = 55 ns		
600 mils				
4 - LCC 32 pins				
T - SOIC 24 pins				

PACKAGE OUTLINE

For the packaging information, refer to chapter 10.

The reference are : Plastic DIL, 300 mils, 24 pins
 Plastic DIL, 600 mils, 24 pins
 SOIC DIL, 300 mils, 24 pins
 Ceramic, 300 mils, 24 pins
 LCC rectangular, 32 pins

BURN-IN SCHEMATICS

